TOSHIBA Diode Silicon Epitaxial Planar Type

1SS201

Ultra High Speed Switching Application

• Low forward voltage : V_F (3) = 0.9V (typ.) • Fast reverse recovery time: t_{rr} = 1.6ns (typ.) • Small total capacitance : C_T = 0.9pF (typ.)

Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit	
Maximum (peak) reverse voltage	V_{RM}	85	V	
Reverse voltage	V _R	80	V	
Maximum (peak) forward current	I _{FM}	300 (*)	mA	
Average forward current	Io	100 (*)	mA	
Surge current (10ms)	I _{FSM}	2 (*)	Α	
Power dissipation	Р	200	mW	
Junction temperature	Tj	125	°C	
Storage temperature range	T _{stg}	-55~125	°C	

^(*) Unit rating. Total rating = Unit rating ×1.5.

Weight: 0.13g

Electrical Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit	
Forward voltage	V _{F (1)}	_	I _F = 1mA	_	0.60	_	_	
	V _{F (2)}	_	I _F = 10mA	_	0.72	_	V	
	V _{F (3)}	_	I _F = 100mA	_	0.90	1.20		
Reverse current	I _{R (1)}	_	V _R = 30V	_	_	0.1	^	
	I _{R (2)}	_	V _R = 80V	_	_	0.5	μΑ	
Total capacitance	C _T	_	V _R = 0, f = 1MHz	_	0.9	3.0	pF	
Reverse recovery time	t _{rr}	_	I _F = 10mA (Fig.1)	_	1.6	4.0	ns	

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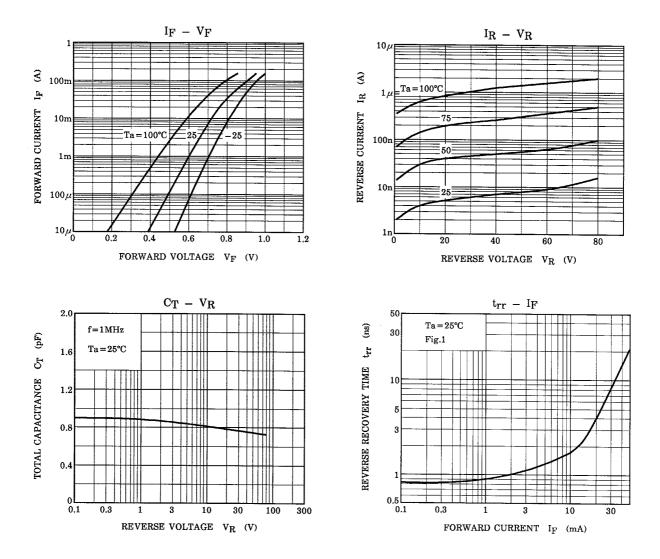
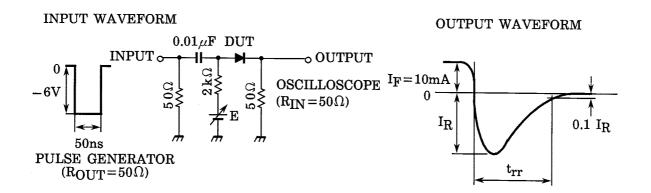


Fig.1 Reverse recovery time (trr) test circuit



2 2001-06-07

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